



JMSL1040AV

100V 29mΩ N-Ch Power MOSFET

Features

- Low Gate Charge
- Low Input Capacitance
- 100% UIS Tested, 100% R_g Tested
- Excepcional R_{DS(ON)} in Low-profile DFN2020-6L
- Pb-free Lead Plating
- Halogen-free and RoHS-compliant

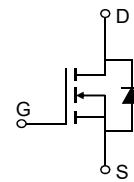
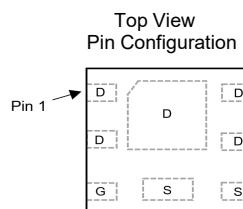
Product Summary

Parameter	Value	Unit
V _{DS}	100	V
V _{GSI(th)} _Typ	1.9	V
I _D (@ V _{GS} = 10V) ⁽¹⁾	4.7	A
R _{DS(ON)} _Typ (@ V _{GS} = 10V)	29	mΩ
R _{DS(ON)} _Typ (@ V _{GS} = 4.5V)	37	mΩ

Applications

- Power Management in Computing, CE, IE 4.0, Communications
- Current Switching in DC/DC & AC/DC Sub-systems
- Power/Load Switching in End Systems of Small Enclosure

U-DFN2020-6L

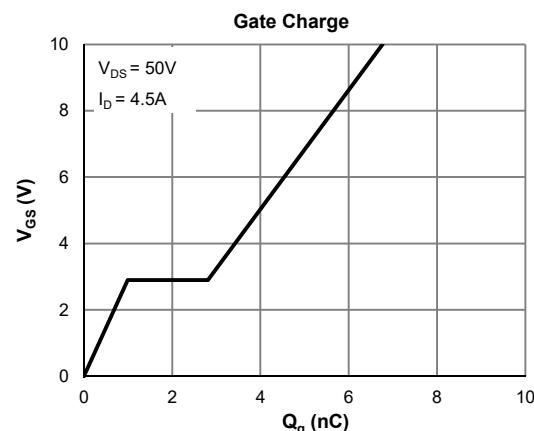
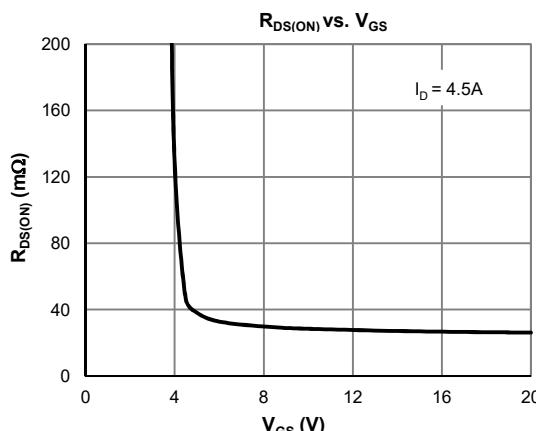


Ordering Information

Device	Package	# of Pins	Marking	MSL	T _J (°C)	Media	Quantity (pcs)
JMSL1040AV-7	U-DFN2020-6L	6	BK	1	-55 to 150	7-inch Reel	3000

Absolute Maximum Ratings (@ T_A = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DS}	100	V
Gate-to-Source Voltage	V _{GS}	±20	V
Continuous Drain Current ⁽¹⁾	I _D	4.7	A
T _A = 70°C		3.8	
Pulsed Drain Current ⁽²⁾	I _{DM}	18.8	A
Avalanche Current ⁽³⁾	I _{AS}	16.0	A
Avalanche Energy ⁽³⁾	E _{AS}	12.8	mJ
Power Dissipation ⁽⁴⁾	P _D	1.5	W
T _A = 25°C		0.94	
T _A = 70°C			
Junction & Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C



**Electrical Characteristics (@ $T_J = 25^\circ\text{C}$ unless otherwise specified)**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	100			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 80\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1.0 5.0	μA
Gate-Body Leakage Current	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.9	2.5	V
Static Drain-Source ON-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 4.5\text{A}$		29	36	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 4\text{A}$		37	48	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{DS} = 5\text{V}, I_D = 4.5\text{A}$		14		S
Diode Forward Voltage	V_{SD}	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.69	1.0	V
Diode Continuous Current	I_S	$T_C = 25^\circ\text{C}$			1	A
DYNAMIC PARAMETERS⁽⁵⁾						
Input Capacitance	C_{iss}	$V_{GS} = 0\text{V}, V_{DS} = 50\text{V}, f = 1\text{MHz}$		363		pF
Output Capacitance	C_{oss}			85		pF
Reverse Transfer Capacitance	C_{rss}			3.0		pF
Gate Resistance	R_g	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$		1.7		Ω
SWITCHING PARAMETERS⁽⁵⁾						
Total Gate Charge (@ $V_{GS} = 10\text{V}$)	Q_g	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 50\text{V}, I_D = 4.5\text{A}$		6.8		nC
Total Gate Charge (@ $V_{GS} = 4.5\text{V}$)	Q_g			3.7		nC
Gate Source Charge	Q_{gs}			1.0		nC
Gate Drain Charge	Q_{gd}			1.8		nC
Turn-On DelayTime	$t_{D(\text{on})}$	$V_{GS} = 10\text{V}, V_{DS} = 50\text{V}$ $R_L = 11\Omega, R_{\text{GEN}} = 6\Omega$		4.9		ns
Turn-On Rise Time	t_r			16.6		ns
Turn-Off DelayTime	$t_{D(\text{off})}$			11.2		ns
Turn-Off Fall Time	t_f			4.9		ns
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 4.5\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		33		ns
Body Diode Reverse Recovery Charge	Q_{rr}	$I_F = 4.5\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		45		nC

Thermal Performance

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	70	85	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	18.0	24	$^\circ\text{C}/\text{W}$

Notes:

1. Computed continuous current assumes the condition of $T_{J_{\text{Max}}}$ while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under $T_{J_{\text{Max}}} = 150^\circ\text{C}$.
3. This single-pulse measurement was taken under the following condition [$L = 100\mu\text{H}, V_{GS} = 10\text{V}, V_{DS} = 50\text{V}$] while its value is limited by $T_{J_{\text{Max}}} = 150^\circ\text{C}$.
4. The power dissipation P_D is based on $T_{J_{\text{Max}}} = 150^\circ\text{C}$.
5. This value is guaranteed by design hence it is not included in the production test.

Typical Electrical & Thermal Characteristics

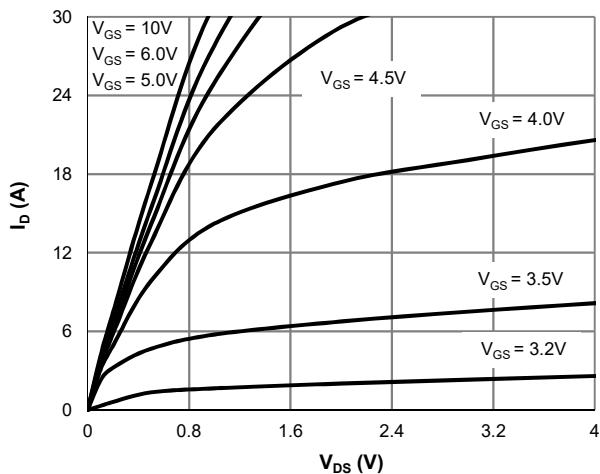


Figure 1: Saturation Characteristics

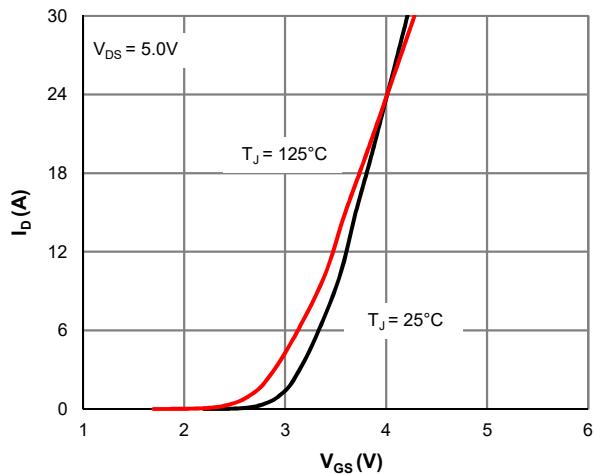


Figure 2: Transfer Characteristics

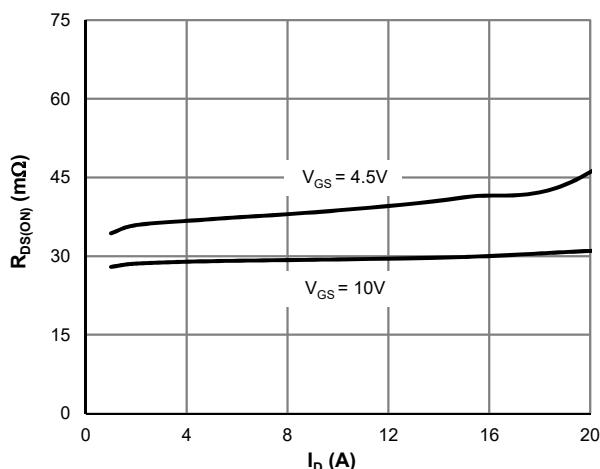


Figure 3: $R_{DS(\text{ON})}$ vs. Drain Current

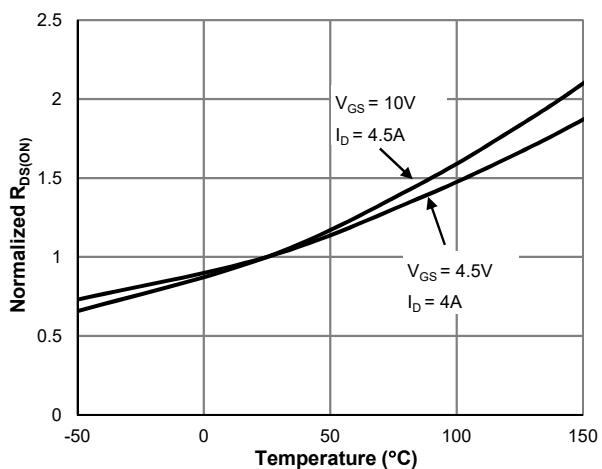


Figure 4: $R_{DS(\text{ON})}$ vs. Junction Temperature

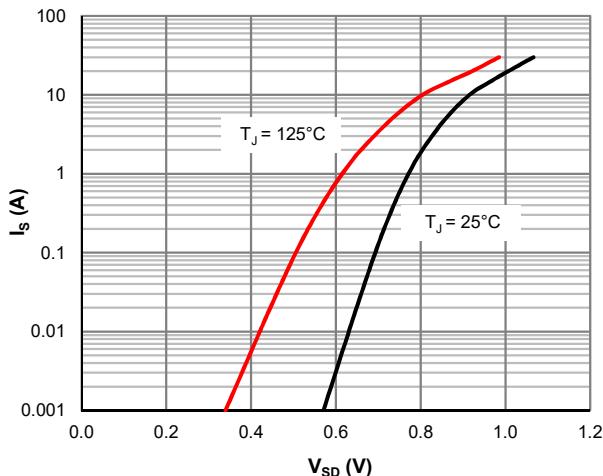


Figure 5: Body-Diode Characteristics

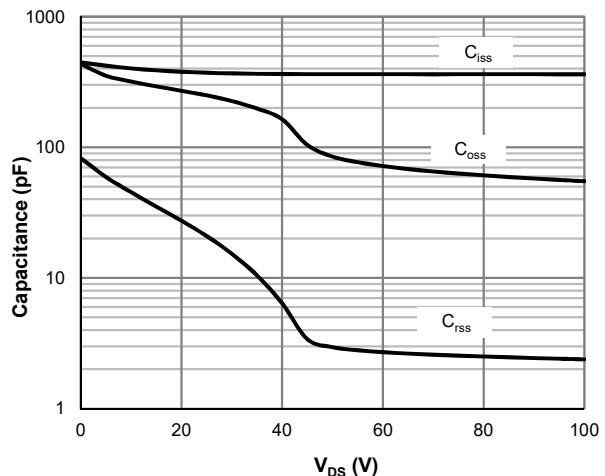


Figure 6: Capacitance Characteristics

Typical Electrical & Thermal Characteristics

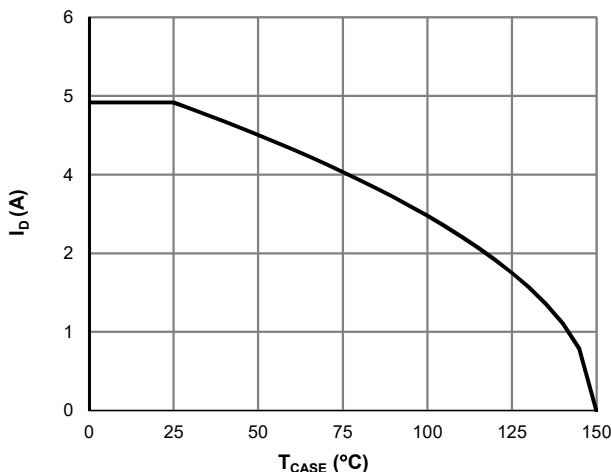


Figure 7: Current De-rating

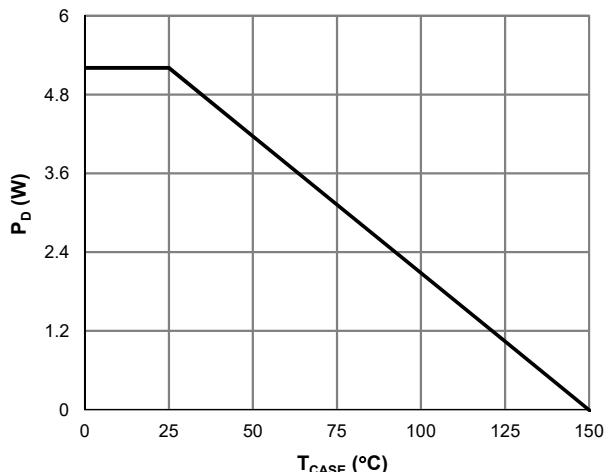


Figure 8: Power De-rating

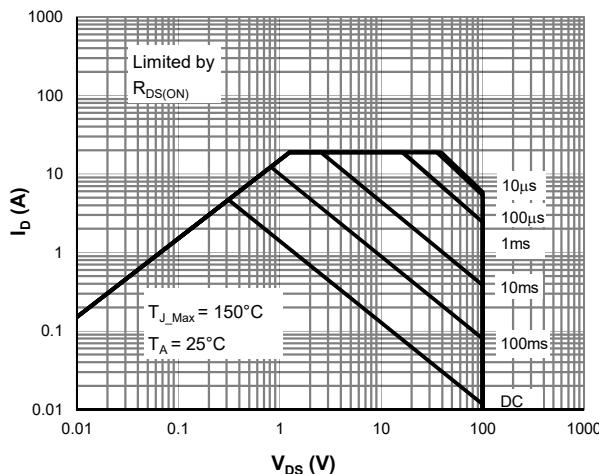


Figure 9: Maximum Safe Operating Area

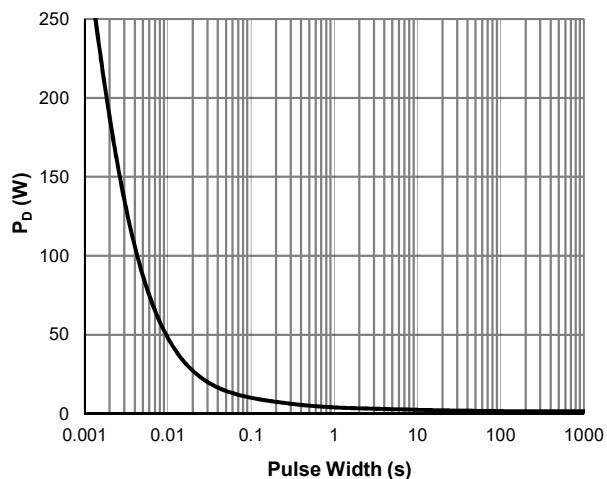


Figure 10: Single Pulse Power Rating, Junction-to-Case

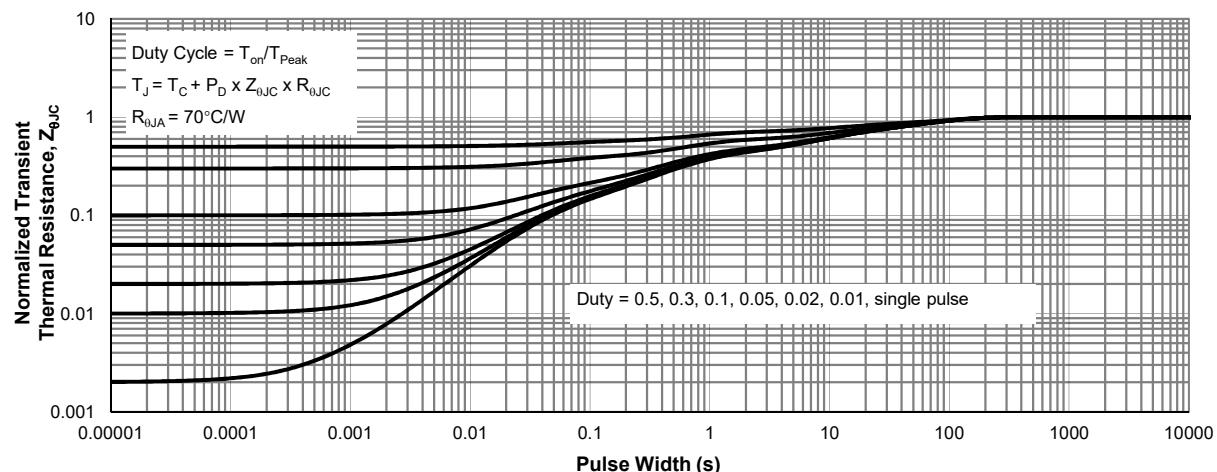
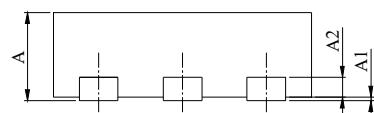
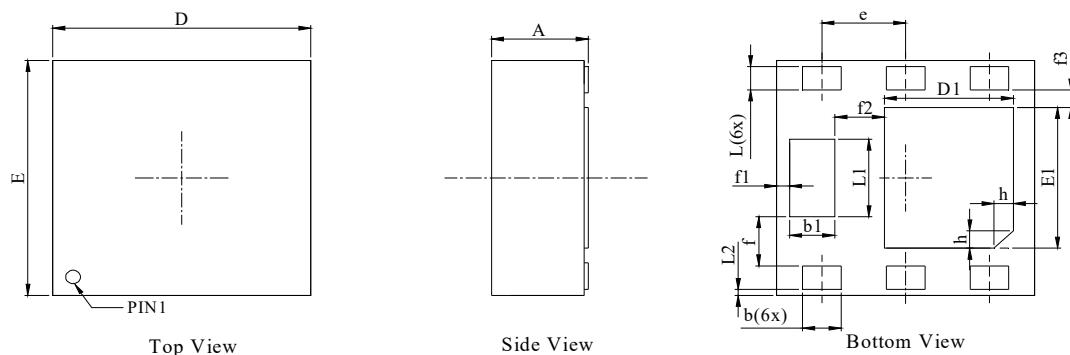
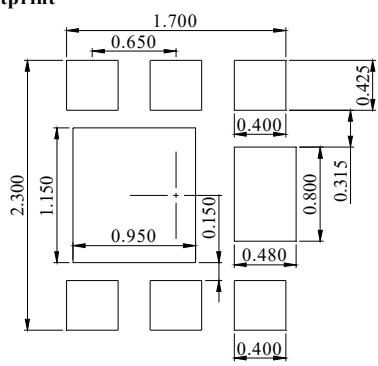


Figure 11: Normalized Maximum Transient Thermal Impedance

U-DFN2020-6L Package Information
Package Outline

Front View

DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	0.500	-	0.600
A1	-	-	0.005
A2	-	0.080	0.250
D	1.900	2.000	2.100
E	1.900	2.000	2.100
D1	0.900	1.000	1.100
E1	1.100	1.200	1.300
b	0.250	0.300	0.350
b1	0.300	0.350	0.400
L	0.150	0.200	0.250
L1	0.610	0.660	0.710
L2	0.010	0.050	0.090
e		0.650 BSC	
f		0.420 REF	
f1		0.100 REF	
f2		0.385 REF	
f3		0.150 REF	
h		0.150 REF	

Recommended Soldering Footprint


DIMENSIONS: MILLIMETERS